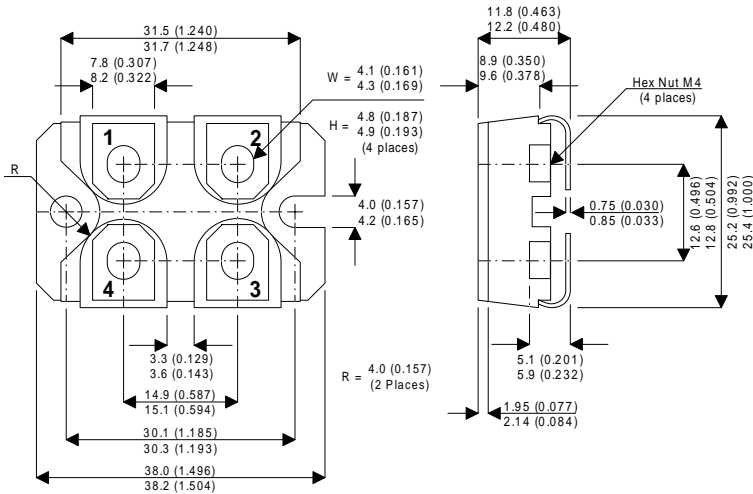


SOT-227 Package Outline.
Dimensions in mm (inches)



4TH GENERATION MOSFET

**N-CHANNEL
ENHANCEMENT MODE
HIGH VOLTAGE
POWER MOSFETS**

V_{DSS} 600V
 $I_{D(cont)}$ 57A
 $R_{DS(on)}$ 0.090 Ω

Terminal 1 Source* **Terminal 2** Drain
Terminal 3 Gate **Terminal 4** Source*

* Source terminals are shorted internally. Current handling capability is equal for either Source terminal.

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^{\circ}C$ unless otherwise stated)

| | | | |
|------------------|---|------------|-----------------|
| V_{DSS} | Drain – Source Voltage | 600 | V |
| I_D | Continuous Drain Current | 57 | A |
| I_{DM}, I_{LM} | Pulsed Drain Current ¹ and Inductive Current Clamped | 228 | A |
| V_{GS} | Gate – Source Voltage | ± 30 | V |
| P_D | Total Power Dissipation @ $T_{case} = 25^{\circ}C$ | 690 | W |
| | Linear Derating Factor | 5.52 | W / $^{\circ}C$ |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -25 to 125 | $^{\circ}C$ |
| T_L | Lead Temperature : 0.063" from Case for 10 Sec. | 300 | |

STATIC ELECTRICAL RATINGS ($T_{case} = 25^{\circ}C$ unless otherwise stated)

| | Characteristic | Test Conditions | Min. | Typ. | Max. | Unit |
|--------------|--|--|------|------|-----------|----------|
| BV_{DSS} | Drain – Source Breakdown Voltage | $V_{GS} = 0V, I_D = 250\mu A$ | 600 | | | V |
| $I_{D(ON)}$ | On State Drain Current ² | $V_{DS} > I_{D(ON)} \times R_{DS(ON)}$ Max $V_{GS} = 10V$ | 57 | | | A |
| $R_{DS(ON)}$ | Drain – Source On State Resistance ² | $V_{GS} = 10V, I_D = 0.5 I_D [Cont.]$ | | | 0.090 | Ω |
| I_{DSS} | Zero Gate Voltage Drain Current ($V_{GS} = 0V$) | $V_{DS} = V_{DSS}$ | | | 250 | μA |
| | | $V_{DS} = 0.8V_{DSS}, T_C = 125^{\circ}C$ | | | 1000 | |
| I_{GSS} | Gate – Source Leakage Current | $V_{GS} = \pm 30V, V_{DS} = 0V$ | | | ± 100 | nA |
| $V_{GS(TH)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 5.0mA$ | 2 | | 4 | V |

1) Repetitive Rating: Pulse Width limited by maximum junction temperature.

2) Pulse Test: Pulse Width < 380 μS , Duty Cycle < 2%

DYNAMIC CHARACTERISTICS

| | Characteristic | Test Conditions | Min. | Typ. | Max. | Unit |
|--------------|--------------------------------|----------------------------------|------|-------|-------|------|
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ | | 11670 | 14000 | pF |
| C_{oss} | Output Capacitance | $V_{DS} = 25V$ | | 1810 | 2530 | |
| C_{rss} | Reverse Transfer Capacitance | $f = 1MHz$ | | 545 | 870 | |
| Q_g | Total Gate Charge ³ | $V_{GS} = 10V$ | | 446 | 670 | nC |
| Q_{gs} | Gate – Source Charge | $V_{DD} = 0.5 V_{DSS}$ | | 64 | 95 | |
| Q_{gd} | Gate – Drain (“Miller”) Charge | $I_D = I_D [Cont.] @ 25^\circ C$ | | 208 | 315 | |
| $t_{d(on)}$ | Turn-on Delay Time | $V_{GS} = 15V$ | | 22 | 45 | ns |
| t_r | Rise Time | $V_{DD} = 0.5 V_{DSS}$ | | 24 | 50 | |
| $t_{d(off)}$ | Turn-off Delay Time | $I_D = I_D [Cont.] @ 25^\circ C$ | | 65 | 95 | |
| t_f | Fall Time | $R_G = 0.6\Omega$ | | 12 | 25 | |

SOURCE – DRAIN DIODE RATINGS AND CHARACTERISTICS

| | Characteristic | Test Conditions | Min. | Typ. | Max. | Unit |
|----------|---|-----------------------------------|------|------|------|---------|
| I_S | Continuous Source Current (Body Diode) | | | | 57 | A |
| I_{SM} | Pulsed Source Current ¹ (Body Diode) | | | | 228 | |
| V_{SD} | Diode Forward Voltage ² | $V_{GS} = 0V, I_S = -I_D [Cont.]$ | | | 1.8 | V |
| t_{rr} | Reverse Recovery Time | $I_S = -I_D [Cont.]$ | 400 | 800 | 1600 | ns |
| Q_{rr} | Reverse Recovery Charge | $di_S / dt = 100A/\mu s$ | 13 | 26 | 50 | μC |

PACKAGE CHARACTERISTICS

| | Characteristic | Min. | Typ. | Max. | Unit |
|-----------------|---|------|------|------|--------|
| L_D | Internal Drain Inductance (Measured From Drain Terminal to Centre of Die) | | 3 | | nH |
| L_S | Internal Source Inductance (Measured From Source Terminals to Source Bond Pads) | | 5 | | |
| $V_{Isolation}$ | RMS Voltage (50–60 Hz Sinusoidal Waveform From Terminals to Mounting Base for 1 Min.) | 2500 | | | V |
| $C_{Isolation}$ | Drain-to-Mounting Base Capacitance | | 70 | | pF |
| Torque | Maximum Torque for Device Mounting Screws and Electrical Terminations | | | 13 | in-lbs |

THERMAL CHARACTERISTICS

| | Characteristic | Min. | Typ. | Max. | Unit |
|-----------------|---|------|------|------|--------------|
| $R_{\theta JC}$ | Junction to Case | | | 0.18 | $^\circ C/W$ |
| $R_{\theta CS}$ | Case to Sink (Use High Efficiency Thermal Joint Compound and Planar Heat Sink Surface.) | | 0.05 | | |

1) Repetitive Rating: Pulse Width limited by maximum junction temperature.

2) Pulse Test: Pulse Width < 380 μs , Duty Cycle < 2%

3) See MIL–STD–750 Method 3471



CAUTION — Electrostatic Sensitive Devices. Anti-Static Procedures Must Be Followed.